Search N	otes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/727,060	SEKI ET AL.
Examiner	Art Unit
Thinh T. Nauven	2818

SEARCHED				
Class	Subclass	Date	Examiner	
257	621	5/2/2005	TTN	
257	618	5/2/2005	TTN	
257	619	5/3/2005	TTN	
257	624	5/3/2005	TTN	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	621	8/23/0	ーカル
EAST	PUB	8/231	TM
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	5/2/2005	TTN		
EAST	5/3/2005	TTN		
EAST	8/23/03	Tra		
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